

# STS12NF30L

## N-channel 30V - 0.008Ω - 12A SO-8 STripFET™ II Power MOSFET

### **General features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub>	۱ <sub>D</sub>
STS12NF30L	30V	<0.009Ω	12A

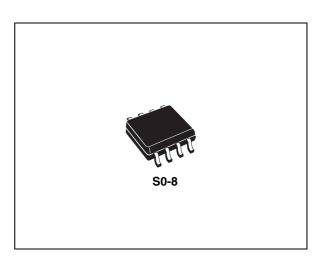
- Standard outline for easy automated surface mount assembly
- Low threshold drive

### Description

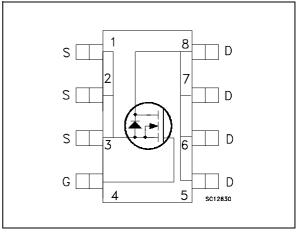
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### Applications

Switching application



### Internal schematic diagram



### Order codes

Part number	Marking	Package	Packaging
STS12NF30L	S12NF30L	SO-8	Tape & reel

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# 1 Electrical ratings

Table 1.	Absolute	maximum	ratings
	Abounde	maximum	radingo

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (v <sub>gs</sub> = 0)	30	V
V <sub>GS</sub>	Gate- source voltage	±16	V
I <sub>D</sub>	Drain current (continuos) at $T_C = 25^{\circ}C$	12	Α
۱ <sub>D</sub>	Drain current (continuos) at $T_C = 100^{\circ}C$	7.5	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	48	Α
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25^{\circ}C$	2.5	W

1. Pulse width limited by safe operating area

Table Z. Thermal data	Table	2.	Thermal	data
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R <sub>thj-a</sub>	Thermal resistance junction-ambient Max	50	°C/W
TJ	Maximum operating junction temperature	150	°C
T <sub>stg</sub>	Storage temperature	-55 to 150	°C



## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 5.	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	30			V
	Zero gate voltage	V <sub>DS</sub> = Max rating			1	μA
IDSS	Drain current (V <sub>GS</sub> = 0)	$V_{DS}$ =Max rating, $T_{C}$ =125°C			10	μA
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 16V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R <sub>DS(on)</sub>	Static drain-source on	$V_{GS} = 10V, I_{D} = 6A$		0.008	0.009	Ω
ייט (on)	resistance	$V_{GS} = 4.5 V$ , $I_{D} = 6 A$		0.01	0.011	Ω

### Table 3. On/off states

#### Table 4. Dynamic

	2 y name					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> = 15V <sub>,</sub> I <sub>D</sub> =6A		15		S
C <sub>iss</sub>	Input capacitance			2400		pF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 25V$ , f = 1 MHz, $V_{GS}$		590		pF
C <sub>rss</sub>	Reverse transfer capacitance	= 0		200		pF
Qg	Total gate charge	V <sub>DD</sub> = 24V, I <sub>D</sub> = 12A,		35	50	nC
Q <sub>gs</sub>	Gate-source charge	$V_{DD} = 24V, I_D = 12A,$ $V_{GS} = 4.5V$		9		nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 13)		18		nC

1. Pulsed: Pulse duration =  $300 \ \mu$ s, duty cycle 1.5.

#### Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD}$ =15 V, I <sub>D</sub> =6A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> = 4.5V (see Figure 12)		35 90		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off-delay time Fall time	$V_{DD} = 15V, I_D = 6A,$ $R_G = 4.7\Omega, V_{GS} =$ 4.5V (see Figure 12)		80 35		ns ns
t <sub>r(Voff)</sub> t <sub>f</sub> t <sub>c</sub>	Off-voltage rise time fall time cross-over time	$V_{DD}$ =24V, I <sub>D</sub> =12A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =4.5V (see Figure 14)		35 35 80		ns ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				40	Α
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				160	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 12A, V_{GS} = 0$			1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 12A, V_{DD} = 15V$ di/dt = 100A/µs, $T_j = 150^{\circ}C$ (see Figure 14)		114 456 8		ns nC A

#### Table 6. Source drain diode

1. Pulse width limited by safe operating area.

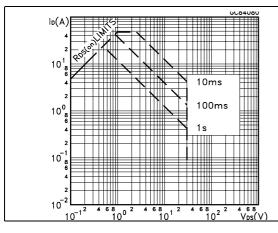
2. Pulsed: Pulse duration = 300  $\mu s,$  duty cycle 1.5%



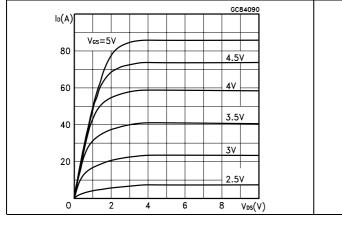
 $\frac{GC83240}{Z_{\text{th}} = k R_{\text{th}J-c}}$  $\delta = t_{p}/\tau$ 

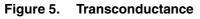
### 2.1 Electrical characteristics (curves)

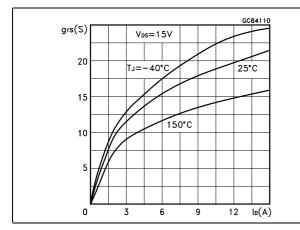
### Figure 1. Safe operating area

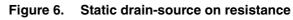


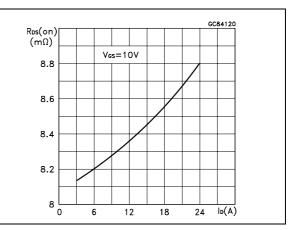




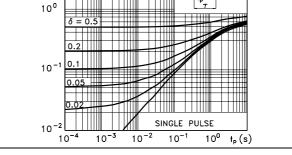








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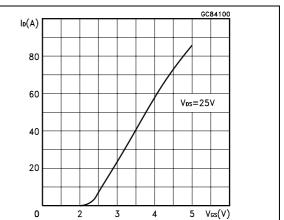


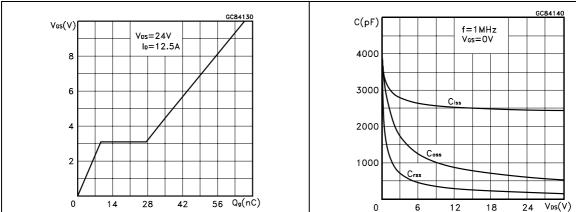
**Thermal impedance** 

Figure 4. Transfer characteristics

Figure 2.

Κ





#### Gate charge vs. gate-source voltage Figure 8. Capacitance variations Figure 7.

Figure 9. Normalized gate threshold voltage vs. temperature

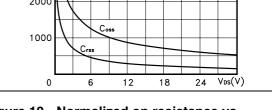


Figure 10. Normalized on resistance vs. temperature

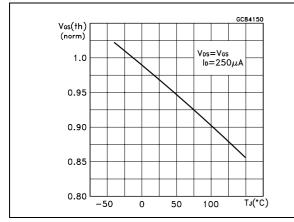
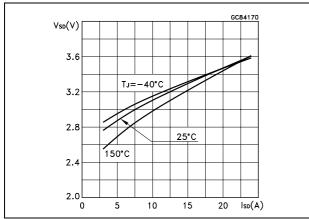
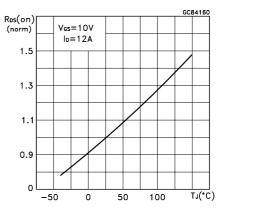


Figure 11. Source-drain diode forward characteristics

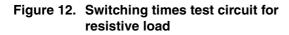






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## 3 Test circuit



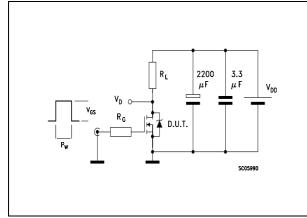
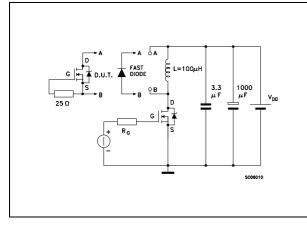
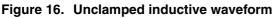
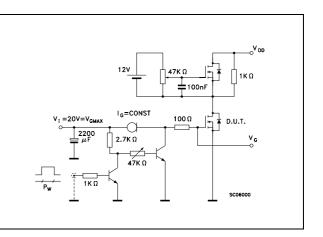
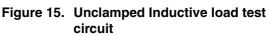


Figure 14. Test circuit for inductive load switching and diode recovery times









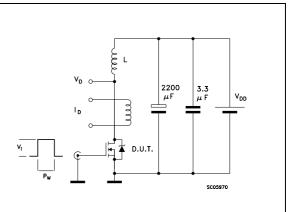
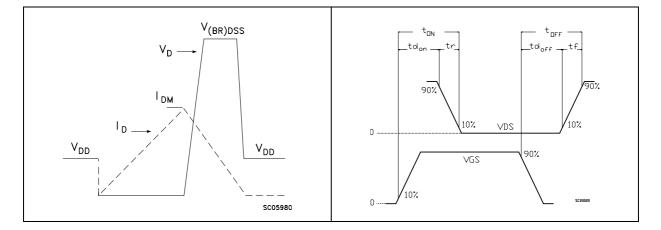


Figure 17. Switching time waveform



### Figure 13. Gate charge test circuit

## 4 Package mechanical data

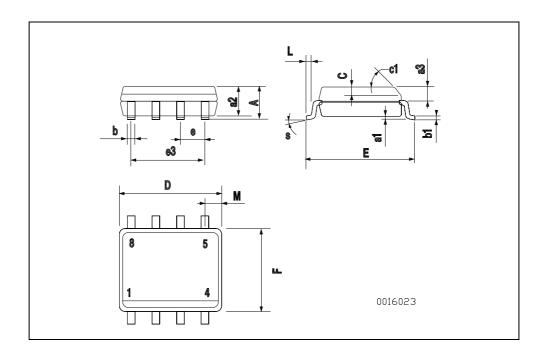
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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023





# 5 Revision history

Date	Revision	Changes
09-Sep-2004	6	Complete version
17-Aug-2006	7	New template, no content change
31-Jan-2007	8	Typo mistake on Table 1.



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